

Content	Page No.
Title of Thesis	i
Certificate	ii
Declaration by the Candidate	iii
Certificate by the Supervisor(s)	iv
Copyright Transfer Certificate	v
Dedication	vi
Acknowledgment	vii-viii
Contents	ix-xiv
List of Figures	xv-xviii
List of symbols/ Abbreviation	xix-xxi
Preface	xxii-xxvii
CHAPTER – 1	1-49
Introduction	
1.1 History of Perovskite	1
1.2 Classification of Perovskite	3
(a) Calcium Titanate CaTiO_3	5
(b) Barium Titanate (BaTiO_3)	5

(c) SrTiO ₃	6
1.3. APPLICATIONS OF PEROVSKITE OXIDES	6-8
1.4. Complex Perovskite	10
1.3. Ceramic Materials	11
1.4. Composite Material	12
1.5. Capacitors	13
1.7. Dielectric Materials	14
1.8. Electronic polarization	16
1.9. Orientation polarization	16
1.10. Space charge polarization	17
1.11. Atomic or ionic polarization	17
1.12. Dielectric Constant	18
1.13. Dielectric loss	19
1.14. Impedance	20
1.15. Magnetic Properties	23
1.15.1. Origine of magnetism	24
1.15.2. Types of Magnetic Materials	27
(I)Paramagnets	27

(II) Diamagnets	29
(III) Ferromagnets	30
(IV) Anti-ferromagnets	31
(V) Ferrimagnetism	32
(VI) Griffith's Phase (T_G)	32
(VII) Super-paramagnets	34
1.15.3.Hysteresis loop	35
1.15.4. Aim of the present study	38
References of chapter 1	40-49
CHAPTER – 2	50-62
Experimental Procedure	
2.1. Experiment	50
2.2. Synthesis of Materials	51
(a) Semi wet Route	51
(b) Chemical method	51
2.3. Calcination Process	51

2.4. Sintering Process	51-53
2.5. X-Ray diffraction Pattern	53-55
2.6. FTIR spectroscopy	55
2.7. Scanning Electron Microscopy (SEM) Analysis	55
2.8. Energy Dispersive X-ray Analysis (EDX)	56
2.9. Transmission Electron Microscopy (TEM) Analysis	57
2.10. X-ray Photoelectron Spectroscopy (XPS)	58
2.11. Raman spectroscopy	59
2.12. Atomic Force Microscopy (AFM) Analysis	60
2.13. Superconducting quantum interference device (SQUID)	60
2.14. Electric and Dielectric Measurement:	60-62
CHAPTER – 3	63-87
Studies on $\text{CaCu}_3\text{Mn}_4\text{O}_{12}$ Ceramic	
3.1. Introduction	63
3.2. Experimental	64
3.3. Results and discussion	64
3.3.1 Microstructural studies	70
3.3.2 Magnetic measurements	76
3.3.3. Dielectric studies	80
3.4. Conclusions	82
References	82-87

CHAPTER – 4	88-110
Studies on $\text{CaCu}_{2.9}\text{Mn}_{0.1}\text{Ti}_{3.9}\text{Mn}_{0.1}\text{O}_{12}$ Ceramic	
4.1. Introduction	88
4.2. Experimental	90
4.3. Results and discussion	91
4.3.1. Microstructural studies	95
4.3.2. Magnetic studies	100
4.3.3. Dielectric studies	102
4.4. Conclusions	104
4.5. References	106-110
CHAPTER – 5	111-126
Studies on $\text{CaCu}_3\text{Ti}_3\text{O}_{12}$ and $\text{CaCu}_3\text{Ti}_{3.9}\text{Mn}_{0.1}\text{O}_{12}$ ceramics	
5.1. Introduction	111
5.2. Experimental	112
5.3. Results and discussion	113
5.3.1. Microstructural studies	117
5.3.2. Magnetic properties	119
5.3.3. Dielectric behavior	120
5.4. Conclusions	122
5.5. References	124-126

CHAPTER – 6	127-149
Studies on $\text{CaCu}_3\text{Ti}_4\text{O}_{12}$ and $\text{CaCu}_2\text{Mn}_1\text{Ti}_4\text{O}_{12}$ ceramics	
6.1. Introduction	127
6.2. Experimental	129
6.3. Results and discussion	130
6.3.1. Microstructural studies	131
6.3.2. Dielectric behavior	141
6.4. Conclusions	145
References	146-149
List of Publication	150-151

	Page No.
Figure 1.1. Classification of Perovskite.	1
Figure 1.2. The structure of complex Perovskite.	3
Figure 1.3. Structure of dielectric capacitor.	9
Figure 1.4. Shows parallel plate capacitors in circuit, including the alignment of charges in the dielectric material [Mark Howard (2015)].	13
Figure 1.5. Depict the polarized and nonpolarized plates of an applied electric field (Saint Jude (2012)).	14
Figure 1.6. Flow chart for the origin of magnetism in the materials.	24
Figure 1.7. Shows the Paramagnetic nature of the material in the absence of applied magnetic field and in the presence of the magnetic field.	27
Figure 1.8. Paramagnetic structure of the materials.	28
Figure 1.9. Displays the diamagnetic materials disperse the line of force a magnetic field.	29
Figure 1.10. Diamagnetic structure .	30
Figure 1.11. Ferromagnetism non-magnetized material and Magnetized material with the corresponding magnetic field .	31
Figure 1.12. Anti-ferromagnetic structure	31
Figure 1.13. Ferromagnetism structure	32
Figure 1.14. Griffith's phase.	33
Figure 1.15. M-H hysteresis loop	35
Figure 1.16. Hysteresis loop or B-H curve	36
Figure 1.17. Applications of magnetic materials	37
Figure 2.1. Flow chart for the synthesis of complex perovskite by the semi-wet route.	53
Figure 2.2. shows the basic concept of X-ray diffraction pattern.	54
Figure 2.3. Powder X-ray diffract meter, Rigaku Miniflex600 (Japan).	54
Figure 2.4. Scanning Electron Microscope (ZEISS, model EVO-18 Research) used for microstructure of the surface of the ceramics.	56
Figure 2.5. Transmission Electron Microscope (TEM, FEI TECANI G ² 20 TWIN, USA) used to determine particle structure.	58
Figure 2.6. The basic principle of Raman spectroscopy	59
Figure 2.7. LCR meter (PSM 1735, Newton 4th Ltd, U.K.) used for dielectric properties measurement.	61

Figure 3.1. shows TGA graph of $\text{CaCu}_3\text{Mn}_4\text{O}_{12}$ as- prepared powder.	66
Figure 3.2. FTIR spectra of CCMO calcined powder at 600 °C for 6 h and sintered at 800 °C for 6 h different temperature.	67
Figure 3.3. XRD pattern for $\text{CaCu}_3\text{Mn}_4\text{O}_{12}$ (CCMO) calcined at 600°C and sintered at 800°C 6 h respectively.	68
Figure 3.4. Raman spectra of $\text{CaCu}_3\text{Mn}_4\text{O}_{12}$ Perovskite oxides sintered at 800°C for 6 h.	69
Figure 3.5.(a) SEM micrographs of calcined at 600°C for 6 h (b) SEM micrographs of sintered at 800°C 6 h showing the needle-like structure and (c) shows the elemental analysis of CCMO ceramic.	72
Figure 3.6. (a) Shows particle size of CCMO, (b) Shows cubical structure of CCMO, (c) Shows the histogram plot Of CCMO particle size and (d) Shows SEAD pattern of CCMO ceramic.	73
Figure 3.7. (a) AFM images of CCMO Ceramic sintered at 800°C for 6 h two-dimensional image showing grains and grain boundaries (b) Three-dimensional image of surface roughness of CCMO (c) Histogram of three-dimensional particle roughness.	74
Figure 3.8 (a) XPS graph of Calcium oxidation state peak recorded at 347.3 eV and 350.7 eV.	76
(b) Shows the Copper oxidation state peak recorded at 934.54 eV and 954.23 eV.	
(c) Shows the Manganese binding energy peak recorded at 641.4 eV and 652.4eV.	
(d) Shows the Oxygen binding energy peak recorded at 529.7 and 531.6 eV.	
Figure 3.9. (a) Temperature dependence of ZFC and FC magnetization plot, top insert indicates dM/dT vs T (b) depicts the M-H hysteresis loop recorded at 5 and 300 k. (C) Shows inverse magnetic susceptibility $1/\chi$ (T) for CCMO measured in the range of 0 to 300 K. The onset temperature T_G , where $1/\chi$ (T) deviates from the linear temperature dependence (solid green line) are indicated by the arrows, showing the signature of Griffith's Phase behavior.	80
Figure 3.10. (a) and (b) display dielectric constant, the tangent loss against	82

frequencies of CCMO ceramic, (c) and (d) tangent loss against temperature at few selected frequencies.

Figure 4.1. TGA plot of dry powder ($\text{CaCu}_{2.90}\text{Mn}_{0.10}\text{Ti}_{3.90}\text{Mn}_{0.10}\text{O}_{12}$ (CCMTMO) as-prepared powder.	92
Figure 4.2. FT-IR spectra of CCMTMO ceramic sintered 900°C for 12 h.	92
Figure 4.3. displays the XRD patterns of the sintered CCMTMO ceramic sintered at 900°C for 12 h.	94
Figure 4.4. displays the Raman shift of CCMTMO ceramic sintered at 900°C for 12 h.	95
Figure 4.5. (a) displays the morphology and microstructure of sintered CCMTMO ceramic and (b) displays Energy Disperse X-ray (EDX) .	96
Figure 4.6. (a) displays the HR-TEM image of sintered CCMTMO ceramic (b) displays the SEAD pattern.	97
Figure 4.7. (a) to (e) display the XPS spectrum of Ca,Cu,Mn,Ti and oxygen respectively.	99
Figure 4.8. (a) displays the magnetization versus magnetic field (b) magnetization versus temperature CCMTMO.	101
Figure 4.9. show (a) and (b) the dielectric constant of CCMTMO ceramic versus temperature and frequency, respectively. (c) and (d) depicts the tangent loss of CCMTMO ceramic versus temperature and frequency respectively.	103
Figure 5.1. (a) and (b) display the TGA graph of CCTO and CCTMO respectively.	114
Figure 5.2. (a) and (b) display the XRD graph of CCTO and CCTMO respectively.	115
Figure 5.3. depict the FT-IR spectra of CCTO and CCTMO sintered 900°C for 12 h.	116
Figure 5.4. shows the Raman spectra of CCTMO ceramic .	117
Figure 5.5. display (a) and (b) the HR-SEM of CCTO and CCTMO ceramic sintered 900°C respectively. (c) and (d) EDX spectrum of CCTO and CCTMO ceramic respectively .	118
Figure 5.6. display (a) The HR-SEM image of CCTMO ceramic (cubical structure),(b) the SEAD pattern of CCTMO ceramic .	119
Figure 5.7. display (a) the magnetization versus magnetic field (b) magnetization versus temperature of CCTO and CCTMO.	120
Figure 5.8. (a) and (c) show the dielectric constant versus frequency and temperature respectively, figure (b) and (d) depicts the tangent loss versus frequency and temperature respectively.	121
Figure 6.1. XRD patterns of (a) CCTO and (b) CCMTO sintered at 1100 °C for 8 h.	131
Figure 6.2. SEM micrographs of (a) CCTO and (b) CCMTO sintered at 1100 °C for 8 h. EDX spectra of (c) CCTO and (b) CCMTO sintered at 1100 °C for 8 h.	133
Figure 6.3. HR-TEM images of the $\text{CaCu}_3\text{Ti}_4\text{O}_{12}$ and $\text{CaCu}_2\text{Mn}_1\text{Ti}_4\text{O}_{12}$ (a)and (C)at sintered at 1100°C for 8 h and (b) and (d) Indexed SAED patterns of the sintered at 1100 °C for 8 h.	134
Figure 6.4. (a) and (c) AFM images of CCMTO Ceramic sintered at 1100°C for 8 h two-dimensional image showing grains and grain	135

boundaries (b) Three-dimensional image of surface roughness of CCTO (d) Histogram of three-dimensional particle roughness.	
Figure 6.5. (a) and (c) AFM images of CCMTO Ceramic sintered at 1100°C for 8 h two-dimensional image showing grains and grain boundaries (b) Three-dimensional image of surface roughness of CCTO (D) Histogram of three-dimensional particle roughness.	136
Figure 6.6. (a) to (d) XPS images of the $\text{CaCu}_3\text{Ti}_4\text{O}_{12}$ and at sintered at 1100°C for 8 h.	138
Figure 6.6. (e) to (i) XPS images of the $\text{CaCu}_2\text{Mn}_1\text{Ti}_4\text{O}_{12}$ and at sintered at 1100°C for 8 h .	139
Figure 6.7. (a) displays to cyclic voltammetry and (b) displays Electrochemical Impedance spectroscopy of the $\text{CaCu}_2\text{Mn}_1\text{Ti}_4\text{O}_{12}$ and $\text{CaCu}_2\text{Mn}_1\text{Ti}_4\text{O}_{12}$ at sintered at 1100°C for 8 h .	141
Figure 6.8. (a) and (b) shows the Variations of dielectric constant (ϵ_r) against frequency at few selected frequency as well as at few selected. (c) and (d) dielectric loss ($\tan \delta$) versus frequency of CCTO ceramic .	153
Figure 6.8. (a) and (b) shows the Variations of dielectric constant (ϵ_r) against frequency at few selected frequency as well as at few selected. (c) and (d) dielectric loss ($\tan \delta$) versus frequency of CCTO ceramic .	142
Figure 6.9. (a) and (b) show the variations of dielectric constant (ϵ_r) against temperature, (c) and (d) dielectric loss ($\tan \delta$) versus temperature of CCTO ceramic.	144